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ABSTRACT OF THE DISCLOSURE

A sorting method of monolithic ceramic capacitors in which high reliable sorting can be efficiently achieved based on measuring an insulating resistance involves first performing a burn-in process, which applies not less than double of the rated voltage at the maximum working temperature to a monolithic ceramic capacitor. Thereafter, a high temperature insulation resistance measuring process, which involves measuring an insulation resistance while applying not less than the rated voltage at a temperature of not less than 70°C to the monolithic ceramic capacitor, is performed so that monolithic ceramic capacitors having abnormal insulation resistances are eliminated. Preferably, the direction of applied voltage in the burn-in process agrees with the direction of applied voltage in the high temperature insulation resistance measuring process.